

Product data sheet

1. General description

Ultrafast diode in a TO3PF package.

2. Features and benefits

- Isolated plastic package
- Low leakage current
- Low reverse recovery current
- Low thermal resistance
- Reduces switching losses in associated MOSFET or IGBT

3. Applications

- Active PFC in air conditioner
- S.M.P.S Power Factor Correction (PFC)
- · Half-bridge / full-bridge switched-mode power supplies

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _R	reverse voltage	DC	-	-	600	V
I _{F(AV)}	average forward current	δ = 0.5 ;T _h ≤ 73 °C; square-wave; Fig. 1; Fig. 2; Fig. <u>3</u>	-	-	30	A
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t _p = 25 µs; square-wave	-	-	60	A
I _{FSM}	non-repetitive peak forward current	t _p = 10 ms; T _{j(init)} = 25 °C; SIN; <u>Fig. 4</u>	-	-	170	А
		t _p = 8.3 ms; T _{j(init)} = 25 °C; SIN	-	-	190	А
Static chara	acteristics	·	· ·			_
V _F	forward voltage	I _F = 30 A; T _j = 25 °C; <u>Fig. 6</u>	-	1.35	1.8	V
		I _F = 30 A; T _j = 150 °C; <u>Fig. 6</u>	-	0.96	-	V
Dynamic ch	naracteristics		· · · ·			
t _{rr}	reverse recovery time	$ I_F = 1 \text{ A}; \text{V}_\text{R} = 30 \text{ V}; \text{d} \text{I}_\text{F}/\text{d} \text{t} = 100 \text{ A}/\mu\text{s}; \\ \text{T}_j = 25 \text{ °C}; \overline{\text{Fig. } 7} $	-	37	65	ns
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/ \mu s; T_j = 25 ^{\circ}\text{C}; Fig. 7$	-	85	-	ns
		I_F = 30 A; V_R = 200 V; dI_F/dt = 200 A/ µs; T_j = 125 °C; Fig. 7	-	138	-	ns

5. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	А	anode		K – K – A
2	К	cathode	°O°	001aaa020
3	А	anode		
mb	n.c.	mounting base; isolated	TO3PF	

6. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
BYV30JT-600P	TO3PF	Plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-3P 'full pack'	TO3PF			

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7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Mi	n Max	Unit
V _{RRM}	repetitive peak reverse voltage		-	600	V
V _{RWM}	crest working reverse voltage		-	600	V
V _R	reverse voltage	DC	-	600	V
I _{F(AV)}	average forward current	δ = 0.5; T _h ≤ 73 °C; square-wave; <u>Fig. 1</u> ; Fig. 2; Fig. 3	-	30	A
I _{O(AV)}	average output current	$\delta = 0.5$; $T_h \le 73$ °C; SQW	-	60	А
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t _p = 25 µs; square-wave	-	60	A
I _{FSM}	non-repetitive peak	t _p = 10 ms; T _{j(init)} = 25 °C; SIN; <u>Fig. 4</u>	-	170	А
	forward current	t _p = 8.3 ms; T _{j(init)} = 25 °C; SIN	-	190	А
T _{stg}	storage temperature		-6	5 175	°C
Tj	junction temperature		-	175	°C

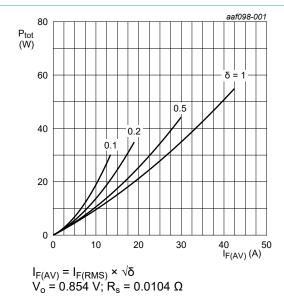
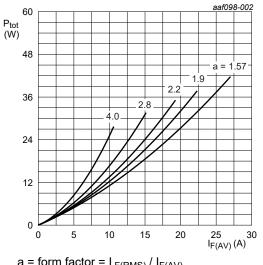


Fig. 1. Forward power dissipation as a function of average forward current; square waveform; typical values



a = form factor = I $_{F(RMS)}$ / I $_{F(AV)}$ V $_{o}$ = 0.854 V; R $_{s}$ = 0.0104 Ω

Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; typical values

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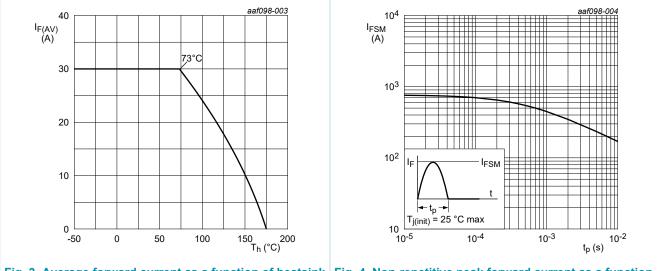


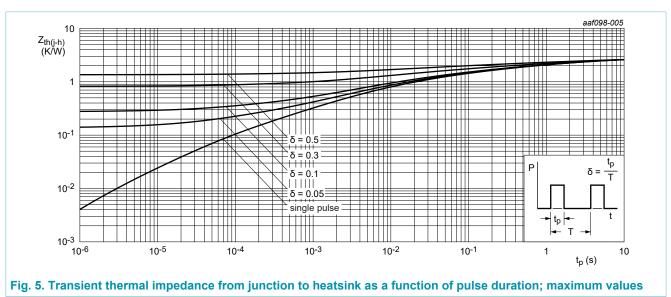
Fig. 3. Average forward current as a function of heatsink
temperature; typical valuesFig. 4. Non-repetitive peak forward current as a function
of pulse width; sinusoidal waveform; maximum values

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8. Thermal characteristics

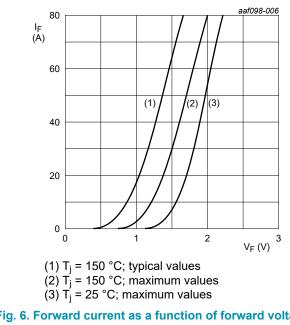
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-h)}	thermal resistance from junction to heatsink	With heatsink compound; Fig. 5	-	2.3	2.6	K/W
R _{th(j-a)}	thermal resistance from junction to ambient free air	in free air	-	35	-	K/W



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9. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V _F	forward voltage	I _F = 30 A; T _j = 25 °C; <u>Fig. 6</u>	-	1.35	1.8	V
		I _F = 30 A; T _j = 150 °C; <u>Fig. 6</u>	-	0.96	-	V
I _R	reverse current	V _R = 600 V; T _j = 25 °C	-	-	10	μA
		V _R = 600 V; T _j = 150 °C	-	-	500	μA
Dynamic ch	naracteristics	· · · · ·				
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{ d}I_F/\text{d}t = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ Fig. 7}$	-	37	65	ns
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ µs; T _j = 25 °C; Fig. 7	-	85	-	ns
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ µs; $T_j = 125 \text{ °C}; Fig. 7$	-	138	-	ns
I _{RM}	peak reverse recovery current	$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ µs; $T_j = 25 \text{ °C}$	-	11	-	A
		$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ µs; $T_j = 125 \text{ °C}$	-	18	-	A
Q _r	recovered charge	$I_F = 30 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ μ s; $T_j = 25 \text{ °C}; Fig. 7$	-	461	-	nC
		I _F = 30 A; V _R = 200 V; dI _F /dt = 200 A/ μs; T _i = 125 °C; <u>Fig. 7</u>	-	1227	-	nC



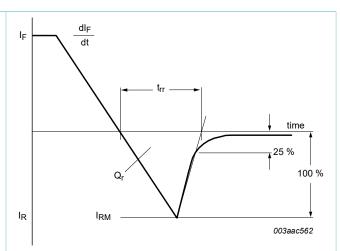


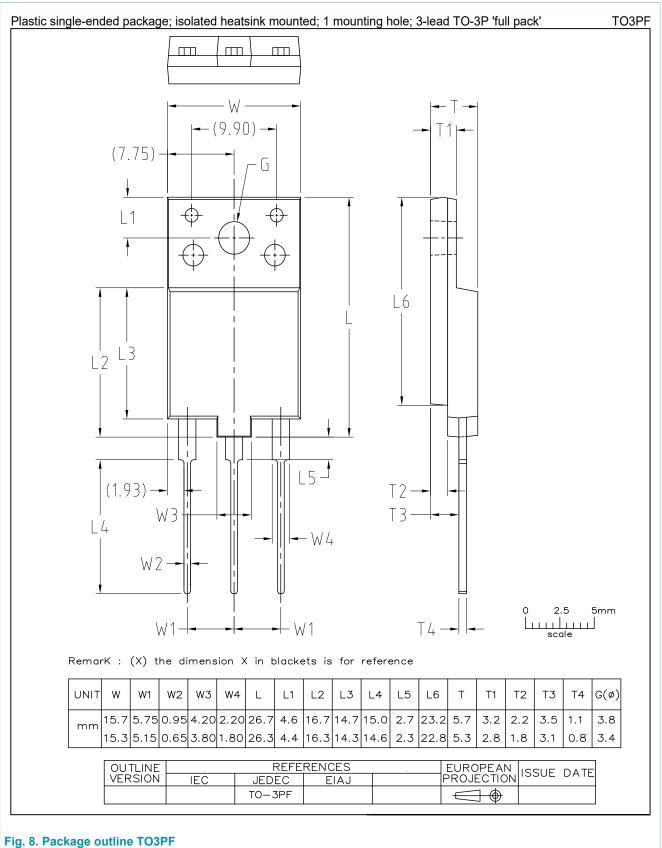


Fig. 6. Forward current as a function of forward voltage



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10. Package outline



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11. Legal information

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Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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